

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/637,433 | | Applicant(s)/Patent Under Reexamination ALDRICH, WILLIAM J. | |
| | Examiner STEVEN B. THERIAULT | | Art Unit 2179 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | A | US-6,069,629 A | 05-2000 | Paterson et al. | 715/808 |
| * | B | US-6,078,739 A | 06-2000 | Paterson et al. | 703/6 |
| * | C | US-6,539,347 B1 | 03-2003 | Paterson et al. | 703/22 |
| * | D | US-2004/0114258 A1 | 06-2004 | Harris et al. | 359/841 |
| * | E | US-7,139,686 B1 | 11-2006 | Critz et al. | 703/2 |
| * | F | US-7,231,333 B2 | 06-2007 | Russell et al. | 703/6 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.